

Additional test cases for Process bus IEDs

1. IED: behaviour of IED when GOOSE subscription fails.
2. IED: behaviour of IED when SV subscription fails.
3. IED: Duplicate GOOSE handling of GOOSE subscriber.
4. IED: Duplicate SV handling of SV subscriber.
5. MU: conditions in which SmpSynch value changes from 2 to 1 to 0.
6. IED: behaviour of IED when SV's SmpSynch value goes from 2 to 1 to 0.
7. Mod/Beh: test cases related to various combination of Test modes (for both GOOSE and SV)
8. LPHD.Sim: test cases related to various combination of Sim modes (for both GOOSE and SV)
9. IED: Behaviour of IED when GOOSE arrives after TAL expiry
10. IED: Behaviour of IED when SVs arrive at the IED's port with varying delays.